Search Notes



| Application/Control No. | Applicant(s)/Patent Under | |
|-------------------------|---------------------------|--|
| | Reexamination | |
| | | |

10511312 TANABE ET AL.

Examiner Art Unit

Yeh, Eueng-nan 2624

SEARCHED

| Class | Subclass | Date | Examiner |
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SEARCH NOTES

| Search Notes | Date | Examiner |
|--|------------|----------|
| (382/232) text search - see search outputs | 2007/11/08 | ey |
| EAST text search - see search outputs | 2007/11/06 | ey |
| PALM inventor search - see search outputs | 2007/11/06 | ey |

INTERFERENCE SEARCH

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